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| Notice of References Cited | Application/Control No. 10/717,838 | | Applicant(s)/Patent Under Reexamination LOCKE ET AL. | |
| | Examiner Eric A. Wiener | | Art Unit 2179 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-2004/0098313 | 05-2004 | Agrawal et al. | 705/026 |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
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FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

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